

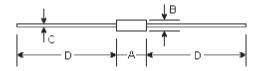
SILICON EPITAXIAL PLANAR DIODE

Features

Silicon Epitaxial Planar Diodes fast switching diode.

This diode is also available in MiniMELF case with the type designation LL4148.

DO-35



DIMENSIONS									
DIM	inches		mm		Note				
	Min.	Max.	Min.	Max.	Note				
Α	-	0.154	1	3.9					
В	-	0.075	1	1.9	ф				
С	-	0.020	-	0.52	ф				
D	1.083	-	27.50	-					

Absolute Maximum Ratings (T_a=25°C)

	Symbols	Values	Units
Reverse Voltage	V _R	75	Volts
Peak reverse voltage	V _{RM}	100	Volts
Rectified current (Average) Half wave rectification with Resist. Load at T _{amb} =25 °C and f≥50Hz	I _o	150 ¹⁾	mA
Surge forward current at t<1s and $T_j \! = \! 25^{\circ}\!\mathrm{C}$	I _{FSM}	500	mA
Power dissipation at $\rm T_{amb} = 25^{\circ}\rm C$	P _{tot}	500 ¹⁾	mW
Junction Temperature	T _j	200	$^{\circ}$ C
Storage temperature range	T _s	-65 to +200	$^{\circ}$

Note:

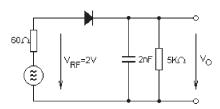
⁽¹⁾ Valid provided that leads at a distance of 8 mm from case are kept at ambient temperature

Characteristics at T₁=25℃

	Symbols	Min.	Тур.	Max.	Units
Forward voltage at I _F =10mA	V _F	-	-	1	Volt
Leakage current at V,=20V at V,=75V at V,=20V, T,=150°C	I I I R I R	- - -	- - -	25 5 50	nA uA uA
Reverse breakdown voltage tested wiht 100uA pulses	V _{(BR)R}	100	-	-	Volts
Capacitance at $V_r = V_R = 0$	C _{tot}	-	-	4	ρF
Voltage rise when switching ON tested with 50mA forward pulses t_p =0.1uS, rise time<30nS, t_p =5 to 100KHz	V _{fr}	-	-	2.5	Volts
Reverse recovery time from I $_{\rm F}$ =10mA to I $_{\rm R}$ =1mA, V $_{\rm R}$ =6V, R $_{\rm L}$ =100 Ω	t,,	-	-	4	nS
Thermal resistance junction to ambient Air	R _{thA}	-	-	0.35 1)	K/mW
Rectification efficiency at f=100MHz, $V_{\rm RF}$ =2V	η _ν	0.45	-	-	-

Note:

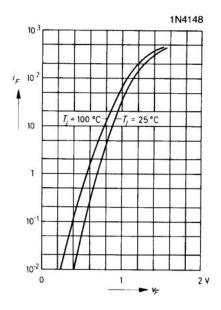
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Rectification efficiency measurement circuit

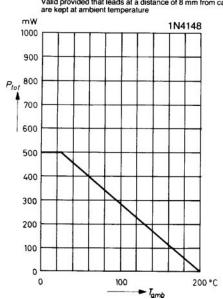
RATINGS AND CHARACTERISTIC CURVES

Forward characteristics

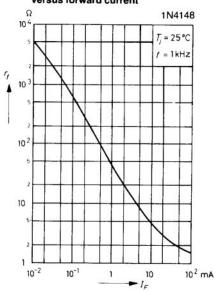


Admissible power dissipation versus ambient temperature

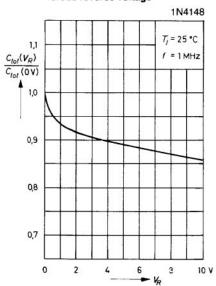
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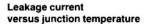
Dynamic forward resistance versus forward current

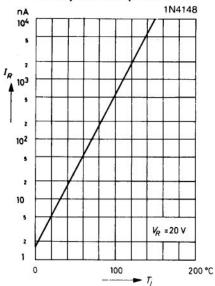


Relative capacitance versus reverse voltage



RATINGS AND CHARACTERISTIC CURVES





Admissible repetitive peak forward current versus pulse duration

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